5	Search	Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination
09/862,755	LI, YE
Examiner	Art Unit
Erin M. File	2634

	SEAR	CHED	
Class	Subclass	Date	Examiner
375	340	12/21/2005	EMF

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
	L		

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST US PAT, USPGPUB, EPO, JPO DERWENT, IBM (text search only— see search history printout)	12/21/2005	EMF
PALM Inventor Search	12/21/2005	EMF